

Attorney Docket No. 04083/LH

**IN THE UNITED STATES PATENT
AND TRADEMARK OFFICE**

Applicant(s): Takashi YONEYAMA, et al.
Serial No. : 10/773,524
Confirm. No.: 7190
Filed : February 6, 2004
For : DEFECT INSPECTION APPARATUS AND
DEFECT INSPECTION METHOD
Art Unit : 2624
Examiner : Tsung Yin Tsai

This paper is being submitted
via EFS-Web on November 17,
2008

In the event that this Paper is
late filed, and the necessary
petition for extension of time
is not filed concurrently
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extension of time, and to the
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PETITION FOR EXTENSION OF TIME

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

S I R :

Applicants hereby petition for a three (3) month extension
of time for timely filing of the papers filed concurrently
herewith.

Extended time expires November 20, 2008.

The Patent Office fee of \$1,110.00 is being paid by credit
card herewith. If any further fees are required, authorization
is given to charge same against Account No. 06-1378.

Respectfully submitted,

/Douglas Holtz/

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